

Cool MOS™ Power Transistor

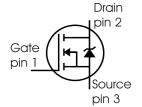
$V_{\rm DS} @ T_{\rm jmax}$ 650 V $R_{\rm DS(on)}$ 0.19 Ω 1D 20.7 A

Feature

- New revolutionary high voltage technology
- Ultra low gate charge
- Periodic avalanche rated
- Extreme dv/dt rated
- High peak current capability
- Improved transconductance
- Qualified according to JEDEC⁰⁾ for target applications

PG-TO263
1 2 3 VPT05164

Туре	Package	Ordering Code	Marking
SPB20N60C3	PG-TO263	Q67040-S4397	20N60C3



Maximum Ratings

Parameter	Symbol	Va	lue	Unit
		SPB		
Continuous drain current	I _D			Α
T _C = 25 °C		20.7		
<i>T</i> _C = 100 °C		13.1		
Pulsed drain current, t_p limited by T_{jmax}	I _{D puls}	62.1		Α
Avalanche energy, single pulse	E _{AS}	690		mJ
I _D =10A, V _{DD} =50V				
Avalanche energy, repetitive t_{AR} limited by T_{jmax}^{2}	E _{AR}	1		
I _D =20A, V _{DD} =50V				
Avalanche current, repetitive t_{AR} limited by T_{jmax}	I _{AR}	20		Α
Gate source voltage static	V_{GS}	±20		V
Gate source voltage AC (f >1Hz)	V_{GS}	±30		
Power dissipation, $T_C = 25^{\circ}C$	P _{tot}	208		W
Operating and storage temperature	T _j , T _{stg}	-55	+150	°C
Reverse diode dv/dt ⁷⁾	dv/dt	15	5	V/ns



Maximum Ratings

Parameter	Symbol	Value	Unit
Drain Source voltage slope	d <i>v</i> /d <i>t</i>	50	V/ns
$V_{\rm DS}$ = 480 V, $I_{\rm D}$ = 20.7 A, $T_{\rm j}$ = 125 °C			

Thermal Characteristics

Parameter	Symbol		Unit		
		min.	typ.	max.	
Thermal resistance, junction - case	R _{thJC}	-	-	0.6	K/W
		-	-		
Thermal resistance, junction - ambient, leaded	R _{thJA}	-	-	62	
		-	-		
SMD version, device on PCB:	R _{thJA}				
@ min. footprint		-	-	62	
@ 6 cm ² cooling area ³⁾		-	35	_	
Soldering temperature, reflow soldering, MSL1	T _{sold}	-	-	260	°C

Electrical Characteristics, at T_i =25°C unless otherwise specified

Parameter	neter Symbol Conditions		Values			Unit
			min.	typ.	max.	
Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0V, I _D =0.25mA	600	-	-	V
Drain-Source avalanche breakdown voltage	V _{(BR)DS}	V _{GS} =0V, I _D =20A	-	700	-	
Gate threshold voltage	V _{GS(th)}	/ _D =1000μA, / _{GS} =V _D	2.1	3	3.9	
Zero gate voltage drain current	I _{DSS}	V _{DS} =600V, V _{GS} =0V,				μA
		<i>T</i> _j =25°C	-	0.1	1	
		<i>T</i> _j =150°C	-	-	100	
Gate-source leakage current	I_{GSS}	V _{GS} =30V, V _{DS} =0V	-	-	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10V, I _D =13.1A				Ω
		<i>T</i> _j =25°C	-	0.16	0.19	
		<i>T</i> _j =150°C	-	0.43	-	
Gate input resistance	R _G	f=1MHz, open drain	-	0.54	-	



Electrical Characteristics

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Transconductance	<i>g</i> fs	V _{DS} ≥2*I _D *R _{DS(on)max} ,	-	17.5	-	S
		I _D =13.1A				
Input capacitance	C _{iss}	V _{GS} =0V, V _{DS} =25V,	-	2400	-	pF
Output capacitance	Coss	f=1MHz	-	780	-	
Reverse transfer capacitance	C _{rss}		-	50	-	
Effective output capacitance,5)	C _{o(er)}	V _{GS} =0V,	-	83	-	
energy related	, ,	V _{DS} =0V to 480V				
Effective output capacitance,6)	C _{o(tr)}		-	160	-	
time related						
Turn-on delay time	<i>t</i> _{d(on)}	V _{DD} =380V, V _{GS} =0/13V,	-	10	-	ns
	, ,	I _D =20.7A,				
		$R_{\rm G}$ =3.6 Ω , $T_{\rm j}$ =125				
Rise time	<i>t</i> _r	V _{DD} =380V, V _{GS} =0/13V,	-	5	-	
Turn-off delay time	<i>t</i> d(off)	I _D =20.7A,	-	67	100	
Fall time	<i>t</i> _f	$R_{\rm G}$ =3.6 Ω	-	4.5	12	

Gate Charge Characteristics

Gate to source charge	Q _{gs}	V _{DD} =480V, I _D =20.7A	-	11	-	nC
Gate to drain charge	Q _{gd}		-	33	-	
Gate charge total	Qg	V _{DD} =480V, I _D =20.7A,	-	87	114	
		V _{GS} =0 to 10V				
Gate plateau voltage	V _(plateau)	V _{DD} =480V, I _D =20.7A	-	5.5	-	V

⁰J-STD20 and JESD22

¹Limited only by maximum temperature

²Repetitve avalanche causes additional power losses that can be calculated as $P_{AV} = E_{AR} * f$.

 $^{^3}$ Device on 40mm*40mm*1.5mm epoxy PCB FR4 with 6cm² (one layer, 70 μ m thick) copper area for drain connection. PCB is vertical without blown air.

 $^{^5}C_{\mathrm{o(er)}}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} . $^6C_{\mathrm{o(tr)}}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS} . $^7I_{\mathrm{SD}}<=I_{\mathrm{D}}$, $\mathrm{di/dt}<=400\mathrm{A/us}$, $V_{\mathrm{DClink}}=400\mathrm{V}$, $V_{\mathrm{peak}}<V_{\mathrm{BR,\,DSS}}$, $T_{\mathrm{j}}<T_{\mathrm{j,max}}$. Identical low-side and high-side switch.

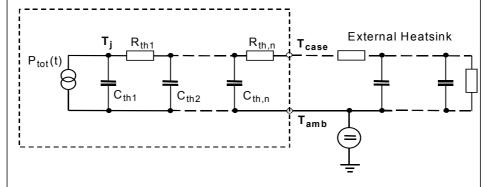


Electrical Characteristics

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Inverse diode continuous	IS	<i>T</i> _C =25°C	-	-	20.7	Α
forward current						
Inverse diode direct current,	I _{SM}		-	-	62.1	
pulsed						
Inverse diode forward voltage	V_{SD}	V _{GS} =0V, I _F =I _S	-	1	1.2	V
Reverse recovery time	t _{rr}	V _R =480V, I _F =I _S ,	-	500	800	ns
Reverse recovery charge	Q _{rr}	d <i>i</i> _F /d <i>t</i> =100A/μs	-	11	-	μC
Peak reverse recovery current	/ _{rrm}		-	70	-	Α
Peak rate of fall of reverse	di _{rr} /dt	<i>T</i> _j =25°C	-	1400	-	A/µs
recovery current						

Typical Transient Thermal Characteristics

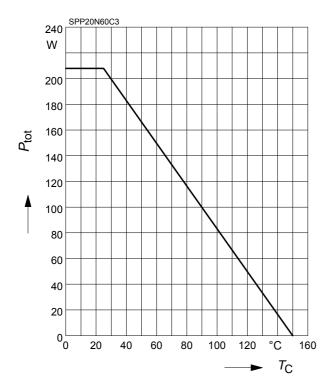
Symbol	Value		Unit	Symbol	Symbol Va		Unit
	SPB				SPB		
R _{th1}	0.00769		K/W	C _{th1}	0.0003763		Ws/K
R _{th2}	0.015			C _{th2}	0.001411		
R _{th3}	0.029			C _{th3}	0.001931		
R _{th4}	0.114			C _{th4}	0.005297		
R _{th5}	0.136			C _{th5}	0.012		
R _{th6}	0.059			C _{th6}	0.091		





1 Power dissipation

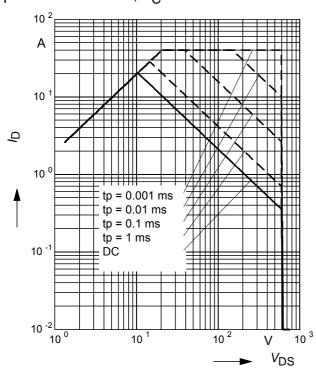
$$P_{\text{tot}} = f(T_{\text{C}})$$



3 Safe operating area

$$I_{\mathsf{D}} = f(\ V_{\mathsf{DS}}\,)$$

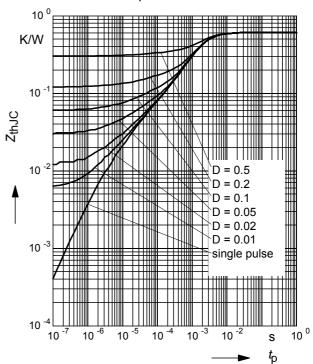
parameter : D = 0 , $T_C = 25^{\circ}C$



2 Transient thermal impedance

$$Z_{\mathsf{thJC}} = f(t_{\mathsf{p}})$$

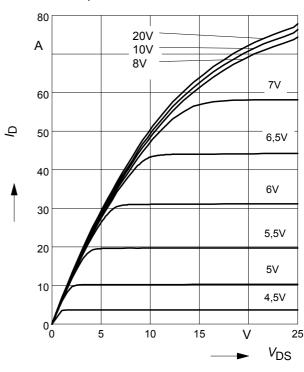
parameter: $D = t_p/T$



4 Typ. output characteristic

 $I_{D} = f(V_{DS}); T_{i}=25^{\circ}C$

parameter: t_p = 10 μ s, V_{GS}

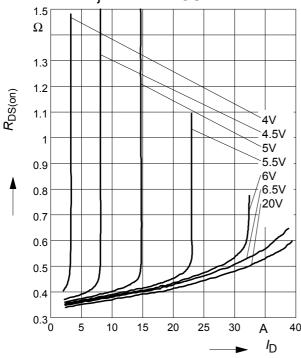




5 Typ. drain-source on resistance

 $R_{DS(on)} = f(I_D)$

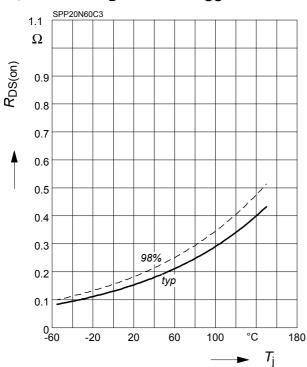
parameter: T_j= 150°C, V_{GS}



7 Drain-source on-state resistance

 $R_{\mathrm{DS}(\mathrm{on})} = f(T_{\mathrm{j}})$

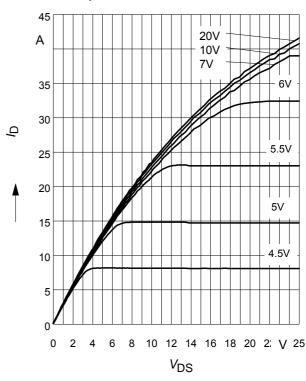
parameter : I_D = 13.1 A, V_{GS} = 10 V



6 Typ. output characteristic

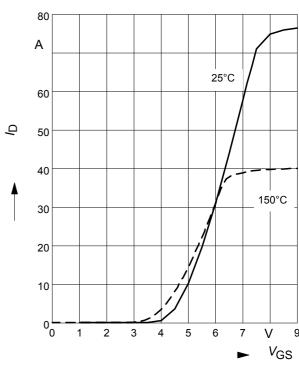
 $I_{D} = f(V_{DS}); T_{j}=150^{\circ}C$

parameter: t_p = 10 μ s, V_{GS}



8 Typ. transfer characteristics

 $I_{\rm D}$ = $f(V_{\rm GS})$; $V_{\rm DS}$ ≥ 2 x $I_{\rm D}$ x $R_{\rm DS(on)max}$ parameter: $t_{\rm p}$ = 10 μ s



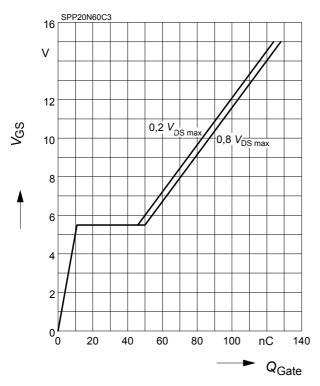
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9 Typ. gate charge

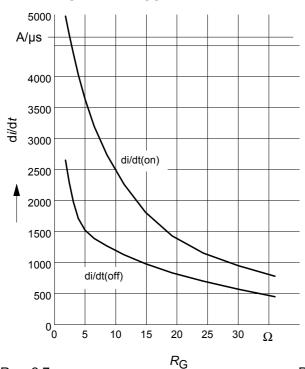
 $V_{GS} = f (Q_{Gate})$

parameter: I_D = 20.7 A pulsed



11 Typ. drain current slope

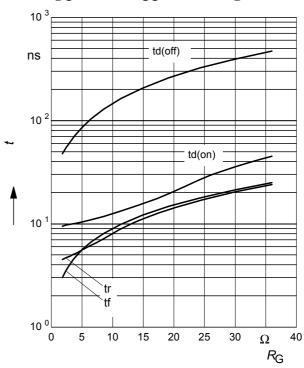
 $di/dt = f(R_G)$, inductive load, $T_j = 125$ °C par.: V_{DS} =380V, V_{GS} =0/+13V, I_D =20.7A



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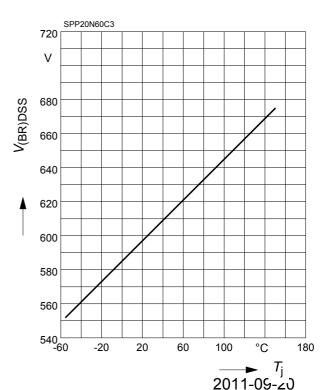
10 Typ. switching time

 $t = f(R_G)$, inductive load, T_j =125°C par.: V_{DS} =380V, V_{GS} =0/+13V, I_D =20.7 A



12 Drain-source breakdown voltage

 $V_{(BR)DSS} = f(T_j)$

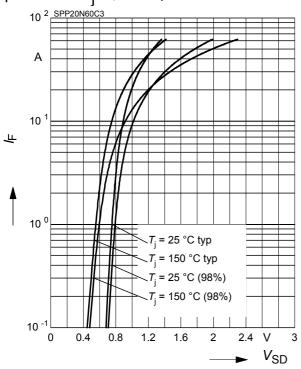




13 Forward characteristics of body diode

 $I_{\mathsf{F}} = f(\mathsf{V}_{\mathsf{SD}})$

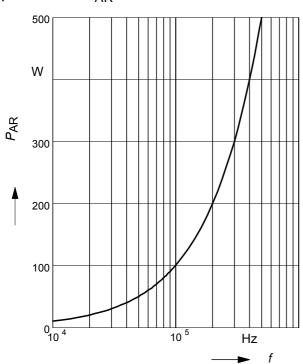
parameter: T, tp = 10 μ s



15 Avalanche power losses

 $P_{\mathsf{AR}} = f(f)$

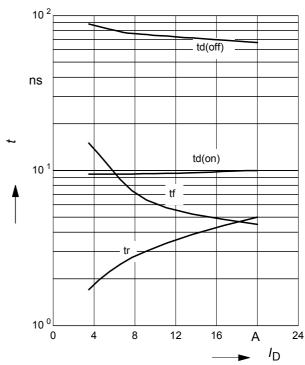
parameter: EAR=1mJ



14 Typ. switching time

 $t = f(I_D)$, inductive load, T_i =125°C

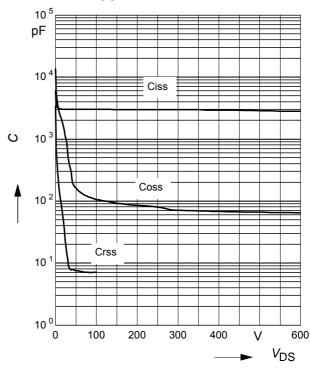
par.: $V_{\rm DS}$ =380V, $V_{\rm GS}$ =0/+13V, $R_{\rm G}$ =3.6 Ω



16 Typ. capacitances

 $C = f(V_{DS})$

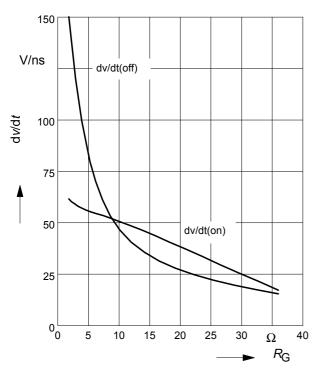
parameter: V_{GS} =0V, f=1 MHz





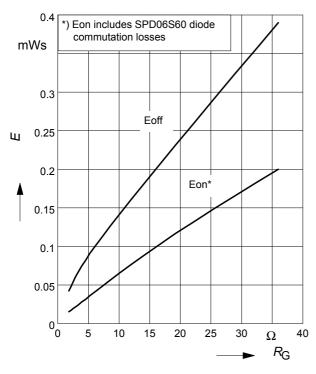
17 Typ. drain source voltage slope

 $dv/dt = f(R_G)$, inductive load, $T_j = 125$ °C par.: $V_{DS} = 380$ V, $V_{GS} = 0/+13$ V, $I_D = 20.7$ A



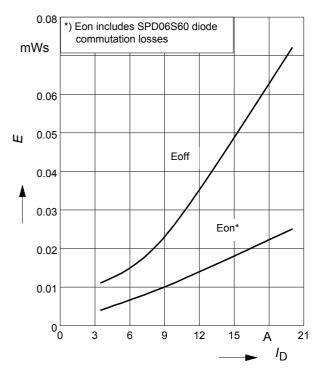
19 Typ. switching losses

 $E = f(R_G)$, inductive load, T_j =125°C par.: V_{DS} =380V, V_{GS} =0/+13V, I_D =20.7A



18 Typ. switching losses

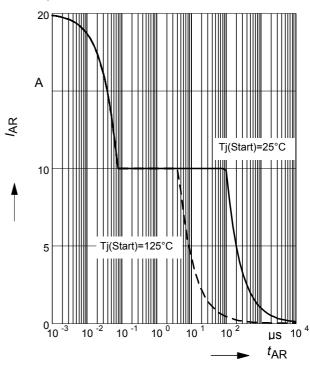
 $E = f(I_D)$, inductive load, T_j =125°C par.: V_{DS} =380V, V_{GS} =0/+13V, R_G =3.6 Ω



20 Avalanche SOA

 $I_{AR} = f(t_{AR})$

par.: $T_j \le 150 \, ^{\circ}\text{C}$

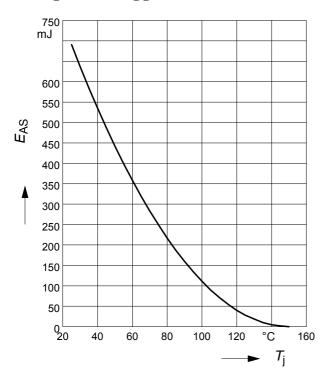




21 Avalanche energy

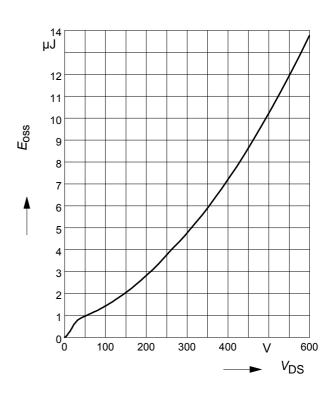
$$E_{AS} = f(T_j)$$

par.: $I_D = 10 \text{ A}, V_{DD} = 50 \text{ V}$

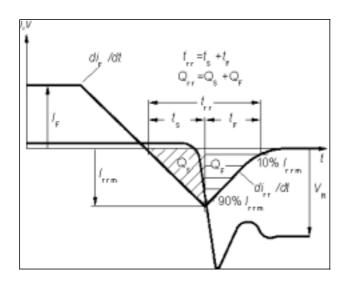


22 Typ. $C_{\rm OSS}$ stored energy

$$E_{\rm oss} = f(V_{\rm DS})$$

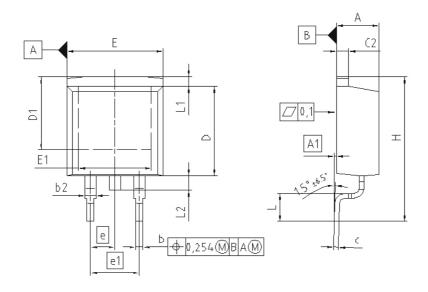


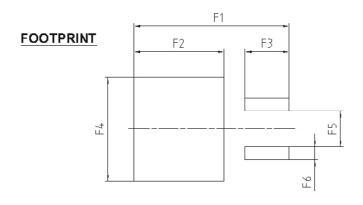
Definition of diodes switching characteristics



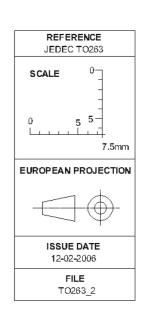


PG-TO263-3-2/ PG-TO263-3-5/ PG-TO263-3-22





DIM	MILLIN	1ETERS	INCHES			
DIM	MIN	MAX	MIN	MAX		
Α	4.300	4.572	0.169	0.180		
A1	0.000	0.254	0.000	0.010		
b	0.650	0.850	0.026	0.033		
b2	0.950	1.321	0.037	0.052		
C	0.330	0.650	0.013	0.026		
c2	0.170	1.400	0.046	0.055		
D	8.509	9.450	0.335	0.372		
D1	7.100	-	0.280	-		
E	9.800	10.312	0.386	0.406		
E1	6.500		0.256			
e	2.	540	0.1	0.100		
e1	5.	080	0.2	200		
N		2	3	2		
н	14.605	15.875	0.575	0.625		
L	2.200	3.000	0.087	0.118		
L1	-	1.600	-	0.063		
L2	1.000	1.778	0.039	0.070		
F1	16.050	16.250	0.632	0.640		
F2	9.300	9.500	0.366	0.374		
F3	4.500	4.700	0.177	0.185		
F4	10.700	10.900	0.421	0.429		
F5	3.630	3.830	0.143	0.151		
F6	1.100	1.300	0.043	0.051		





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